Notice of References Cited Application/Control No. 10/523,847 Examiner Yonel Beaulieu Applicant(s)/Patent Under Reexamination HORTNER ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2005/0060066	03-2005	Buehler et al.	701/002
*	В	US-5,444,624	08-1995	Wilkinson et al.	703/8
*	С	US-5,388,990	02-1995	Beckman, Brian C.	434/38
*	D	US-6,088,527	07-2000	Rybczynski, Zbigniew	396/1
*	Ε	US-6,464,130	10-2002	Itoh et al.	228/245
	F	US-			
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
_	К	US-			
	L	US-		. •	
	М	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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